## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10733040	NAKAMURA, TAKESHI	
Examiner	Art Unit	
Ensey, Brian	2615	

SEARCHED				
Class	Subclass	Date	Examine	

SEARCH NOTES				
Search Notes	Date	Examiner		
Discussed with Sinh Tran	1/19/07	BE		
Discussed with Paul Harper (AU 2626), Dan Swerdlow (AU 2615) and Walter Briney III (AU 2615)	1/19/07	BE		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	

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